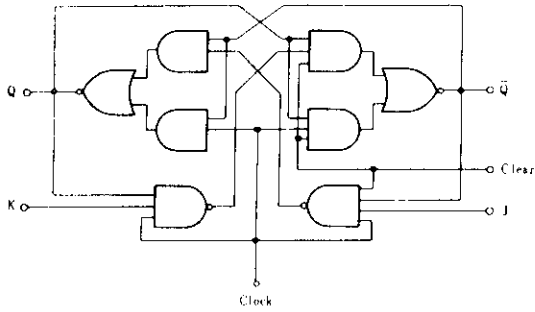
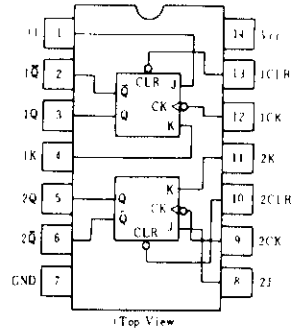


HD74LS107A ● Dual J-K Negative-edge-triggered Flip-Flops (with Clear)

■ BLOCK DIAGRAM (1/2)



■ PIN ARRANGEMENT



■ RECOMMENDED OPERATING CONDITIONS

Item	Symbol	min	typ	max	Unit
Clock frequency	f_{clock}	0	-	30	MHz
Pulse width	Clock High	20	-	-	ns
	Clear Low	25	-	-	ns
Setup time	"H" Data	20↓	-	-	ns
	"L" Data	20↓	-	-	ns
Hold time	t_h	0↓	-	-	ns

Note) ↓; The arrow indicates the falling edge.

■ FUNCTION TABLE

Inputs				Outputs	
Clear	Clock	J	K	Q	\bar{Q}
L	X	X	X	L	H
H	↓	L	L	Q_0	\bar{Q}_0
H	↓	H	L	H	L
H	↓	L	H	L	H
H	↓	H	H	Toggle	
H	H	X	X	Q_0	\bar{Q}_0

Notes) H; high level, L; low level, X; irrelevant

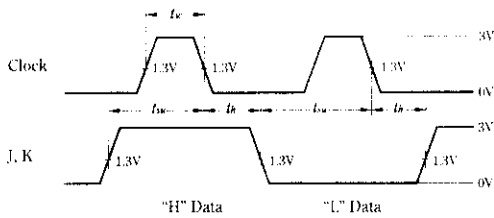
↓; transition from high to low level

Q_0 ; level of Q before the indicated steady-state input conditions were established.

\bar{Q}_0 ; complement of Q_0 or level of \bar{Q} before the indicated steady-state input conditions were established.

Toggle; each output changes to the complement of its previous level on each active transition indicated by ↓.

■ TIMING DEFINITION



■ ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +75^\circ\text{C}$)

Item	Symbol	Test Conditions	min	typ*	max	Unit	
Input voltage	V_{IH}		2.0	—	—	V	
	V_{IL}		—	—	0.8	V	
Output voltage	V_{OH}	$V_{CC} = 4.75\text{V}, V_{IH} = 2\text{V}, V_{IL} = 0.8\text{V}, I_{OH} = -400\mu\text{A}$	2.7	—	—	V	
	V_{OL}	$V_{CC} = 4.75\text{V}, V_{IH} = 2\text{V}$	—	—	0.5	V	
		$V_{IL} = 0.8\text{V}$	$I_{OL} = 8\text{mA}$	—	—	0.4	V
Input current	J, K Clear Clock	I_{IH}	$V_{CC} = 5.25\text{V}, V_I = 2.7\text{V}$	—	—	20	μA
				—	—	60	
				—	—	80	
	J, K Clear Clock	I_{IL}	$V_{CC} = 5.25\text{V}, V_I = 0.4\text{V}$	—	—	-0.4	mA
				—	—	-0.8	
				—	—	-0.8	
	J, K Clear Clock	I_i	$V_{CC} = 5.25\text{V}, V_I = 7\text{V}$	—	—	0.1	mA
				—	—	0.3	
—				—	0.4		
Short-circuit output current	I_{OS}	$V_{CC} = 5.25\text{V}$	-20	—	-100	mA	
Supply current **	I_{CC}	$V_{CC} = 5.25\text{V}$	—	4	6	mA	
Input clamp voltage	V_{IK}	$V_{CC} = 4.75\text{V}, I_{IK} = -18\text{mA}$	—	—	-1.5	V	

* $V_{CC} = 5\text{V}, T_a = 25^\circ\text{C}$

** With all outputs open, I_{CC} is measured with the Q and \bar{Q} outputs high in turn. At the time of measurement, the clock input is grounded.

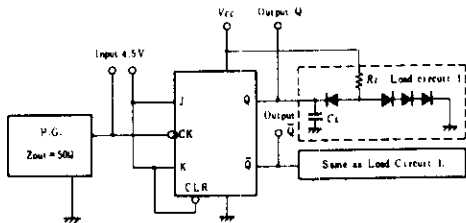
■ SWITCHING CHARACTERISTICS ($V_{CC} = 5\text{V}, T_a = 25^\circ\text{C}$)

Item	Symbol	Inputs	Outputs	Test Conditions	min	typ	max	Unit
Maximum clock frequency	f_{max}			$C_L = 15\text{pF}, R_L = 2\text{k}\Omega$	30	45	—	MHz
Propagation delay time	t_{PLH}	Clear	Q, \bar{Q}		—	15	20	ns
	t_{PHL}	Clock			—	15	20	ns

■ TESTING METHOD

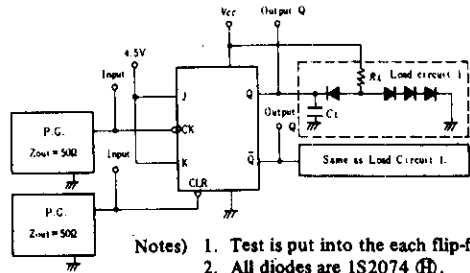
1) Test Circuit

1.1) $f_{max}, t_{PLH}, t_{PHL}$ (Clock \rightarrow Q, \bar{Q})



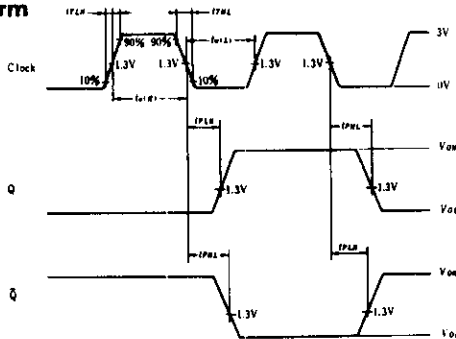
- Notes) 1. Test is put into the each flip-flop.
2. All diodes are 1S2074 (D).
3. C_L includes probe and jig capacitance.

1.2) t_{PHL} (Clear \rightarrow Q), t_{PLH} (Clear \rightarrow \bar{Q})

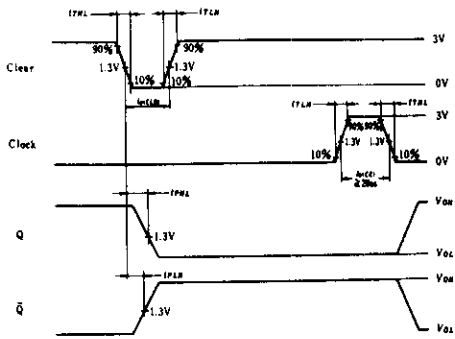


- Notes) 1. Test is put into the each flip-flop.
2. All diodes are 1S2074 (D).
3. C_L includes probe and jig capacitance.

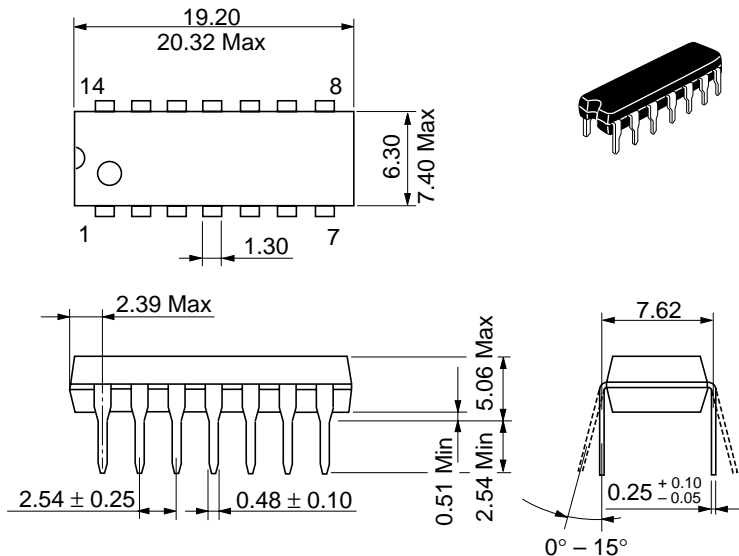
Waveform



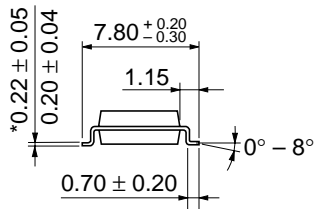
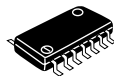
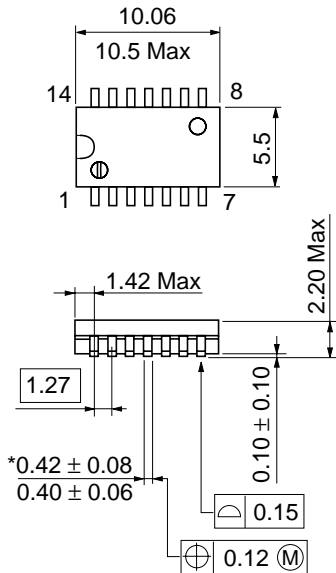
Note) Clock input pulse: $t_{TLH} \leq 15\text{ns}, t_{THL} \leq 6\text{ns}, \text{PRR} = 1\text{MHz}$, duty cycle=50% and: for $f_{max}, t_{TLH} = t_{THL} \leq 2.5\text{ns}$.



Note) Clear and clock input pulse: $t_{TLH} \leq 15\text{ns}, t_{THL} \leq 6\text{ns}, \text{PRR} = 1\text{MHz}$

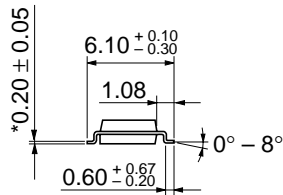
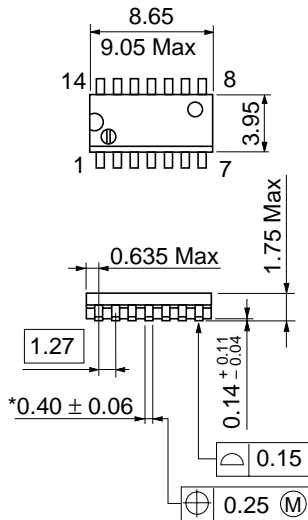


Hitachi Code	DP-14
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	0.97 g



Hitachi Code	FP-14DA
JEDEC	—
EIAJ	Conforms
Weight (reference value)	0.23 g

*Dimension including the plating thickness
Base material dimension



Hitachi Code	FP-14DN
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	0.13 g

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